21A, 30V DUAL N-CHANNEL ENHANCEMENT MODE POWER MOSFET

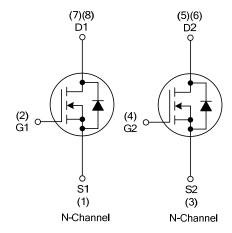
■ DESCRIPTION

The UTC **UTT21NN03** is a N-channel Power MOSFET, it uses UTC's advanced technology to provide the customers with low Rdson characteristic by high cell density trench technology.

■ FEATURES

- * $R_{DS(ON)} \le 21m\Omega$ @ $V_{GS}=10V$, $I_D=10.5A$ $R_{DS(ON)} \le 35m\Omega$ @ $V_{GS}=4.5V$, $I_D=10.5A$
- * Fast Switching Speed
- * Simple Drive Requirement

■ SYMBOL

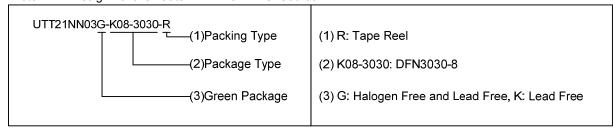


1 DFN3030-8

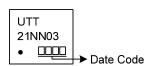
■ ORDERING INFORMATION

Ordering Number		Dookogo	Pin Assignment							Doolsing	
Lead Free	Halogen Free	Package	1	2	3	4	5	6	7	8	Packing
UTT21NN03L-K08-3030-R	UTT21NN03G-K08-3030-R	DFN3030-8	S1	G1	S2	G2	D2	D2	D1	D1	Tape Reel

Note: Pin Assignment: G: Gate D: Drain S: Source



MARKING



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■ **ABSOLUTE MAXIMUM RATINGS** (T_A=25°C, unless otherwise specified)

PARAMETER		SYMBOL	RATINGS	UNIT
Drain-Source Voltage		V_{DSS}	30	V
Gate-Source Voltage		V_{GSS}	±20	V
Drain Current	Continuous	I_{D}	21	Α
	Pulsed (Note 2)	I_{DM}	42	Α
Avalanche Energy Single Pulsed (Note 3)		E _{AS}	23.8	mJ
Peak Diode Recovery dv/dt (Note 3)		dv/dt	1.06	V/nS
Power Dissipation		P_{D}	1.66	W
Junction Temperature		T_J	+150	°C
Storage Temperature		T_{STG}	-55 ~ + 150	°C

Notes: 1. Absolute maximum ratings are those values beyond which the device could be permanently damaged. Absolute maximum ratings are stress ratings only and functional device operation is not implied.

- 2. Repetitive Rating: Pulse width limited by maximum junction temperature.
- 3. L=1mH, I_{AS} =6.9A, V_{DD} =50V, R_G = 25 Ω , Starting T_J = 25 $^{\circ}$ C
- 4. $I_{SD} \le 21A$, di/dt $\le 200A/\mu s$, $V_{DD} \le V_{(BR)DSS}$, $T_J = 25^{\circ}C$.

■ THERMAL DATA

PARAMETER	SYMBOL	RATINGS	UNIT
Junction to Ambient	θ_{JA}	75	°C/W

Note: Device mounted on FR-4 substrate P_C board, 2oz copper, with 1inch square copper plate.

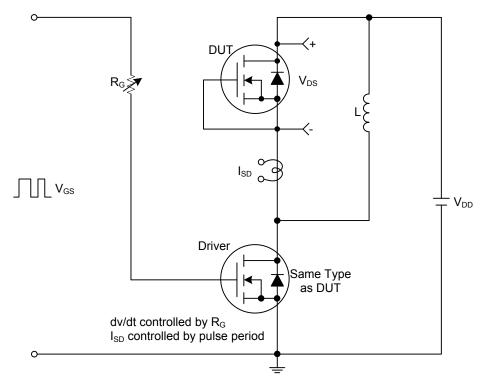
■ ELECTRICAL CHARACTERISTICS (T_J=25°C, unless otherwise specified)

PARAMETER		SYMBOL	TEST CONDITIONS	TYP	MAX	UNIT			
OFF CHARACTERISTICS									
Drain-Source Breakdown Voltage		BV _{DSS}	V_{GS} =0V, I_D =250 μ A	30			V		
Drain-Source Leakage Current		I _{DSS}	V_{DS} =30V, V_{GS} =0V			1	μΑ		
Gate-Source Leakage Current	Forward	I _{GSS}	V _{DS} =0V ,V _{GS} =20V			100	nA		
	Reverse	IGSS	V_{DS} =0V , V_{GS} =-20V			-100	nA		
ON CHARACTERISTICS									
Gate Threshold Voltage		$V_{GS(TH)}$	$V_{DS}=V_{GS}$, $I_{D}=250\mu A$	8.0		2.0	V		
Drain-Source On-State Resistance		D	V _{GS} =10V, I _D =10.5A			21	mΩ		
Dialii-Source Oil-State Resistar	ice	R _{DS(ON)}	V_{GS} =4.5V, I_{D} =10.5A			35	mΩ		
DYNAMIC PARAMETERS									
Input Capacitance		C_{ISS}			394		pF		
Output Capacitance		Coss	V_{GS} =0V, V_{DS} =25V, f=1.0MHz		85		pF		
Reverse Transfer Capacitance		C_{RSS}			71		pF		
SWITCHING PARAMETERS									
Total Gate Charge (Note 1)		Q_G	\/ -20\/ \/ -10\/ -21A		13		nC		
Gate-Source Charge		Q_GS	V_{DS} =30V, V_{GS} =10V, I_{D} =21A, I_{G} =1mA (Note 1, 2)		1.8		nC		
Gate-Drain Charge		Q_GD	IG-IIIIA (Note 1, 2)		2.4		nC		
Turn-ON Delay Time (Note 1)		$t_{D(ON)}$			7		ns		
Turn-ON Rise Time		t_R	V_{DS} =30V, V_{GS} =10V, I_{D} =21A,		15		ns		
Turn-OFF Delay Time		t _{D(OFF)}	R _G =25Ω (Note 1, 2)		39		ns		
Turn-OFF Fall Time					32		ns		
SOURCE- DRAIN DIODE RATINGS AND CHARACTERISTICS									
Maximum Body-Diode Continuous Current		Is				21	Α		
Maximum Body-Diode Pulsed Current		I_{SM}				42	Α		
Drain-Source Diode Forward Voltage (Note 1)		V_{SD}	I _S =21A, V _{GS} =0V			1.3	V		
Body Diode Reverse Recovery	Time (Note 1)	t _{rr}	I _S =21A, V _{GS} =0V,		192		ns		
Body Diode Reverse Recovery Charge		Q_{rr}	dI _F /dt=50A/μs		0.1		nC		

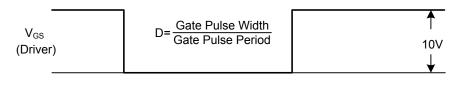
Notes: 1. Pulse Test: Pulse width ≤ 300µs, Duty cycle ≤ 2%.

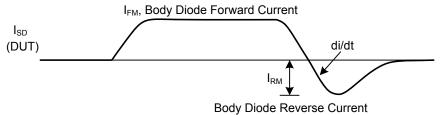
2. Essentially independent of operating temperature.

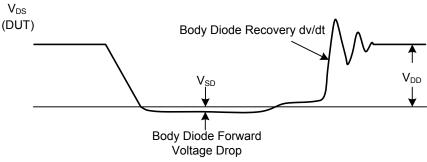
■ TEST CIRCUITS AND WAVEFORMS



Peak Diode Recovery dv/dt Test Circuit



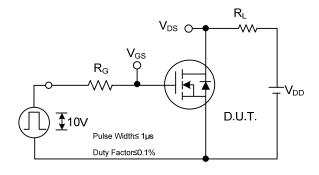


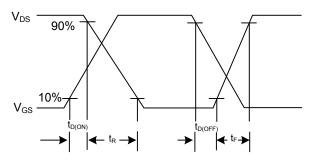


Peak Diode Recovery dv/dt Test Circuit and Waveforms

Peak Diode Recovery dv/dt Waveforms

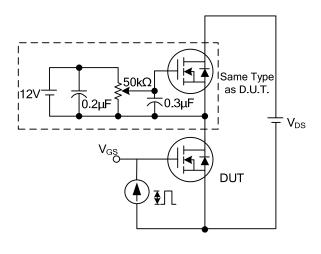
■ TEST CIRCUITS AND WAVEFORMS

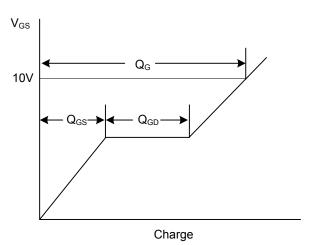




Switching Test Circuit

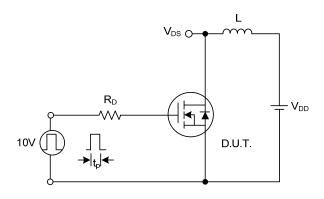
Switching Waveforms

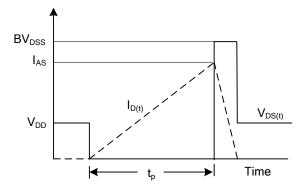




Gate Charge Test Circuit

Gate Charge Waveform

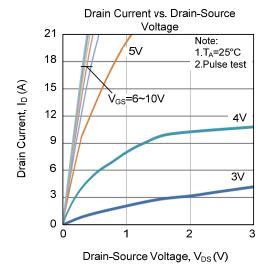


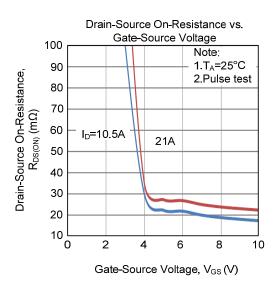


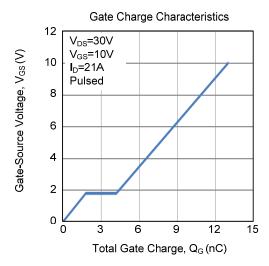
Unclamped Inductive Switching Test Circuit

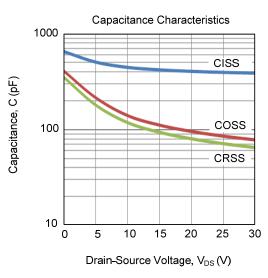
Unclamped Inductive Switching Waveforms

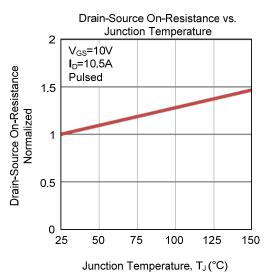
■ TYPICAL CHARACTERISTICS

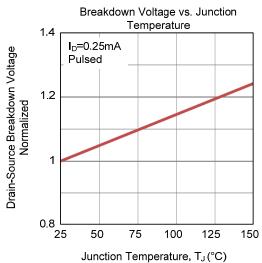




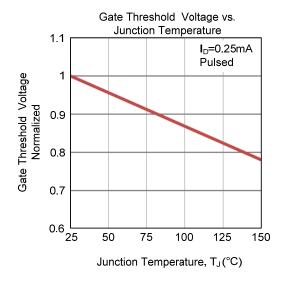


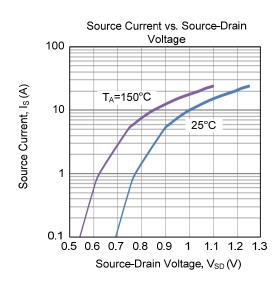


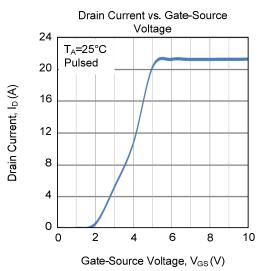


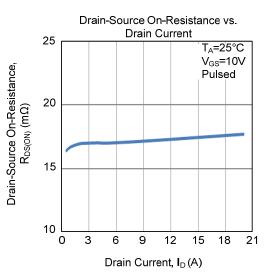


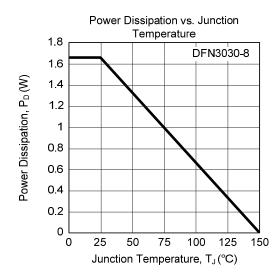
■ TYPICAL CHARACTERISTICS (Cont.)

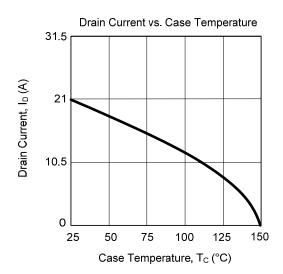




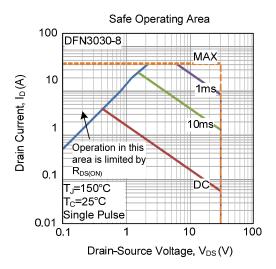








■ TYPICAL CHARACTERISTICS (Cont.)



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